



Deep Learning and Computer Vision for Object Recognition

Guest Editors:

Dr. Eleonora Iotti

Department of Mathematical,
Physical and Computer Sciences,
University of Parma, 43124
Parma, Italy

Dr. Vincenzo Bonnici

Department of Mathematical,
Physical and Computer Sciences,
University of Parma, 43124
Parma, Italy

Dr. Flavio Bertini

Department of Mathematical,
Physical and Computer Sciences,
University of Parma, 43124
Parma, Italy

Deadline for manuscript
submissions:

closed (30 October 2023)

Message from the Guest Editors

In the last decade, we have witnessed the increasing significance of deep learning techniques and deep neural network architectures in artificial intelligence (AI) research, especially in the field of computer vision. These methods have contributed to important advances in image processing and pattern recognition (e.g., object detection), becoming a de facto standard in approaching such tasks. Deep learning for computer vision is still a very fast-growing scientific branch, as shown by recent work on transformers and ConvNet models. The task of object recognition, that is, the identification of specific objects within an image or frame sequence, aims to localize and classify items that are of interest in a wide range of applications.

This Special Issue aims to explore recent advances and trends in the use of deep learning and computer vision methods for object recognition, and seeks original contributions that point out possible ways to deal with scarce and heterogeneous input data, as well as the variability of input domains. This includes but is not limited to meta-learning techniques, one-shot or few-shot learning, data augmentation, and fast or real-time object detection.





an Open Access Journal by MDPI

Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo

Dipartimento di Fisica,
Politecnico di Milano, Piazza L.
da Vinci 32, 20133 Milano, Italy

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Author Benefits

Open Access: free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility: indexed within Scopus, SCIE (Web of Science), Inspec, CAPlus / SciFinder, and other databases.

Journal Rank: JCR - Q1 (Engineering, Multidisciplinary) / CiteScore - Q1 (General Engineering)

Contact Us

Applied Sciences Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland

Tel: +41 61 683 77 34
www.mdpi.com

mdpi.com/journal/applsci
applsci@mdpi.com
[X@Applsci](https://twitter.com/Applsci)